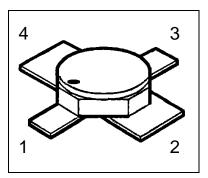


HiRel NPN Silicon Germanium RF Transistor

- HiRel Discrete and Microwave Semiconductor
- High gain ultra low noise RF transistor
- Outstanding noise figure F = 0.7 dB at 1.8 GHz Outstanding noise figure F = 1.0 dB at 6 GHz
- Hermetically sealed microwave package
- **@CSA Space Qualified** ESCC Detail Spec. No.: 5611/011

ESD: Electrostatic discharge sensitive device, observe handling precautions!



Туре	Marking	Pin Configuration				Package
		1	2	3	4	
BFY740B-01	-	С	Е	В	E	Micro-X

Maximum Ratings

Parameter	Symbol	Values	Unit	
Collector-emitter voltage $T_a > 0 \ ^{\circ}C$ $T_a \le 0 \ ^{\circ}C$	V _{CEO}	4.0 3.5	V V	
Collector-base voltage	V _{CBO}	13	V	
Emitter-base voltage	V _{EBO}	1.2	V	
Collector current ¹⁾	Ι _C	30	mA	
Base current	I _B	3	mA	
Junction temperature	Tj	175	°C	
Operating temperature range	T _{op}	-65+175	°C	
Storage temperature range	T _{stg}	-65+175	°C	
Thermal Resistance				
Junction-soldering point ²⁾	R _{th JS}	400	K/W	

Notes .:

1) For $T_S \le 125^{\circ}$ C. For $T_S > 125^{\circ}$ C derating is required.

2) T_S is measured on the emitter lead at the soldering point to the pcb.

IFAG PMM RFS D HIR



Electrical Characteristics

at T_A=25°C; unless otherwise specified

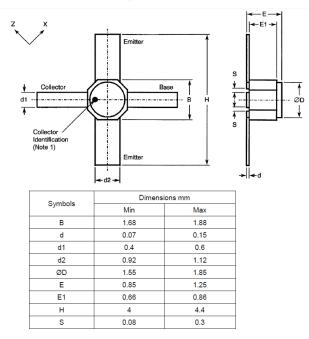
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics					
Collector-base cutoff current	I _{CBO}	-	-	10	μA
$V_{CB} = 5 V, I_{E} = 0$					
Collector-emitter cutoff current 1)	I _{CEX}	-	-	200	μA
$V_{CE} = 4.0 \text{ V}, I_B = 0.1 \mu\text{A}$					
Emitter-base cuttoff current	I _{EBO}	-	-	5	μA
$V_{EB} = 1.2 \text{ V}, I_{C} = 0$					
DC current gain	h _{FE}	130	270	480	-
$I_{C} = 20 \text{ mA}, V_{CE} = 3 \text{ V}$					
AC Characteristics					
Collector-base capacitance	C _{CB}	-	0.07	-	pF
$V_{CB} = 2 V$, $V_{BE} = vbe = 0$, f = 1 MHz					
Collector-emitter capacitance	C _{CE}	-	0.45	-	pF
$V_{CE} = 2 V$, $V_{BE} = vbe = 0$, f = 1 MHz					
Emitter-base capacitance	C _{EB}	-	0.6	-	pF
$V_{EB} = 0.5V$, $V_{CB} = vcb = 0$, f = 1 MHz					
Noise Figure ($Z_S = Z_{sopt}$)	F				dB
$I_{C} = 8 \text{ mA}, V_{CE} = 3 \text{ V}, f = 1.8 \text{ GHz}$		-	0.7	-	
$I_{\rm C} = 8$ mA, $V_{\rm CE} = 3$ V, f = 6.0 GHz	1	-	1.0	-	
Insertion power gain ($Z_S = Z_L = 50 \Omega$)	S _{21e} ²				dB
$I_{C} = 20 \text{ mA}, V_{CE} = 3 \text{ V}, f = 1.8 \text{ GHz}$ $I_{C} = 20 \text{ mA}, V_{CE} = 3 \text{ V}, f = 6.0 \text{ GHz}$		-	24 14	-	
Power gain ($Z_S = Z_{Sopt}$, $Z_L = Z_{Lopt}$)	G _{ms} ²⁾				dB
I_{C} = 20 mA, V_{CE} = 3 V, f = 1.8 GHz		-	26.5	-	
Power gain ($Z_S = Z_{Sopt}$, $Z_L = Z_{Lopt}$)	G _{ma} ²⁾				dB
$I_{C} = 20 \text{ mA}, V_{CE} = 3 \text{ V}, f = 6.0 \text{ GHz}$		-	18.3	-	

Notes.: 1) This Test assures V(BR)CE0 > 4.0V

2)
$$G_{ma} = \left| \frac{S21}{S12} \right| (k - \sqrt{k^2 - 1}), \quad G_{ms} = \left| \frac{S21}{S12} \right|$$



Micro-X Package



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